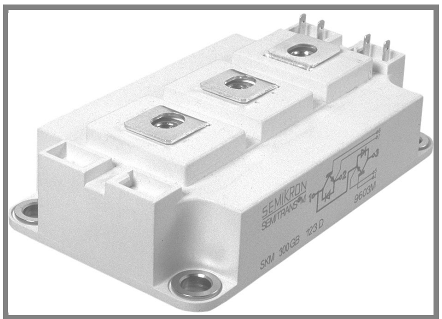
SKM 300GB125D



SEMITRANS™ 3

Ultra Fast IGBT Module

SKM 300GB125D

Preliminary Data

Features

- N channel, homogeneous Silicon structure (NPT - Non punch-through IGBT)
- Low inductance case
- Short tail current with low temperature dependence
- High short circuit capability, self limiting
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding Technology
- Large clearance (10 mm) and creepage distances (20 mm)

Typical Applications

- Switched mode power supplies at f_{sw} > 20 kHz
- Resonant inverters up to 100 kHz
- Silent AC motor speed control (elevators)
- Inductive heating
- Silent UPS Uninterruptable power supplies at f_{sw} > 20 kHz
- Electronic (also portable) welders at f_{sw} > 20 kHz

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Absolute Maximum Ratings		T_c = 25 °C, unless otherwise specified	
Symbol	**Conditions**	**Values**	**Units**
IGBT			
V_{CES}		1200	V
I_C	T_c = 25 (80) °C	300 (210)	A
I_{CRM}	t_p = 1 ms	400	A
V_{GES}		± 20	V
T_{vj}, (T_{stg})	$T_{OPERATION} \leq T_{stg}$	- 40 ... + 150 (125)	°C
V_{isol}	AC, 1 min.	4000	V
Inverse diode			
I_F	T_c = 25 (80) °C	260 (180)	A
I_{FRM}	t_p = 1 ms	400	A
I_{FSM}	t_p = 10 ms; sin.; T_j = 150 °C	2200	A

Characteristics			T_c = 25 °C, unless otherwise specified		
Symbol	**Conditions**	**min.**	**typ.**	**max.**	**Units**
IGBT					
$V_{GE(th)}$	$V_{GE} = V_{CE}$, I_C = 8 mA	4,5	5,5	6,5	V
I_{CES}	V_{GE} = 0, $V_{CE} = V_{CES}$, T_j = 25 (125) °C		0,1	0,3	mA
$V_{CE(TO)}$	T_j = 25 (125) °C		1,5 (1,7)	1,75	V
r_{CE}	V_{GE} = 15 V, T_j = 25 (125) °C		9 (11,5)	10,5	mΩ
$V_{CE(sat)}$	I_{Cnom} = 200 A, V_{GE} = 15 V, chip level		3,3 (4)	3,85	V
C_{ies}	under following conditions		18	24	nF
C_{oes}	V_{GE} = 0, V_{CE} = 25 V, f = 1 MHz		2,5	3,2	nF
C_{res}			1	1,3	nF
L_{CE}				20	nH
$R_{CC'+EE'}$	res., terminal-chip T_c= 25 (125) °C		0,35 (0,5)		mΩ
$t_{d(on)}$	V_{CC} = 600 V, I_{Cnom} = 200 A		130		ns
t_r	$R_{Gon} = R_{Goff}$ = 3 Ω, T_j = 125 °C		40		ns
$t_{d(off)}$	V_{GE} = ± 15 V		460		ns
t_f			30		ns
E_{on} (E_{off})			16 (11)		mJ
Inverse diode					
$V_F = V_{EC}$	I_{Fnom} = 200 A; V_{GE} = 0 V; T_j = 25 (125) °C		2 (1,8)	2,5	V
$V_{(TO)}$	T_j = 125 () °C		1,1	1,2	V
r_T	T_j = 125 () °C		3	5,5	mΩ
I_{RRM}	I_{Fnom} = 200 A; T_j = 125 ( ) °C		340		A
Q_{rr}	di/dt = 8000 A/µs		46		µC
E_{rr}	V_{GE} = 0 V		13,6		mJ
Thermal characteristics					
$R_{th(j-c)}$	per IGBT			0,075	K/W
$R_{th(j-c)D}$	per Inverse Diode			0,18	K/W
$R_{th(c-s)}$	per module			0,038	K/W
Mechanical data					
M_s	to heatsink M6	3		5	Nm
M_t	to terminals M6	2,5		5	Nm
w				325	g

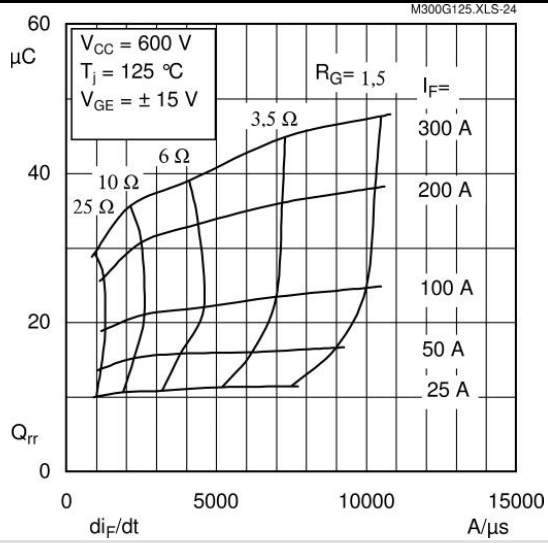
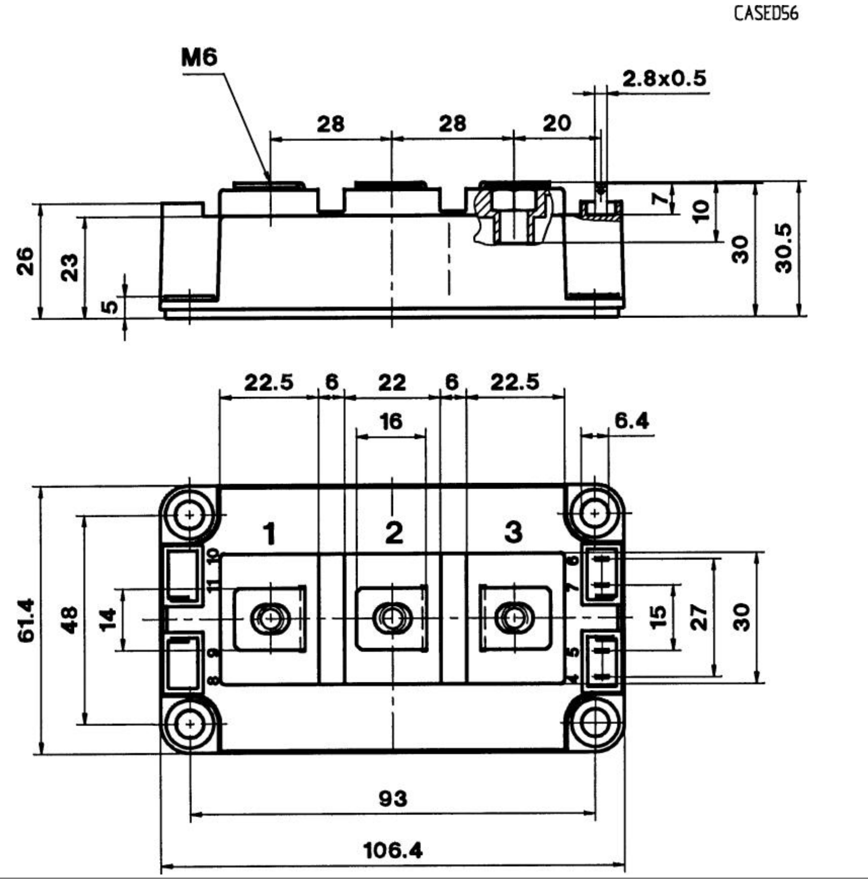


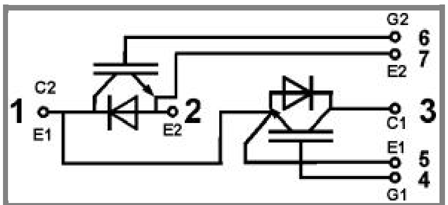
Fig. 13 Typ. CAL diode recovered charge

UL Recognized
File no. E 63 532

Dimensions in mm



Case D 56



GB Case D 56

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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